Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/670,787	HAN ET AL.	
Examiner	Art Unit	
Jason M. Han	2875	

SEARCHED			
Class	Subclass	Date	Examiner
362	39-30	6/11/2005	JMH
362	97	6/11/2005	ЈМН
362	260	6/11/2005	ЈМН
349	70	6/11/2005	ЈМН

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCI (INCLUDING SEA	H NOTES ARCH STRATEG	Y)
	DATE	EXMR
Search History	6/11/2005	ЈМН
P.E. Stephen Husar	6/11/2005	ЈМН
Inventor Search	6/11/2005	ЈМН